



## PATENT APPLICATION

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FORM PTO-1449	ATTY. DKT NO.	01-156	SER. NO.	09/877,028
	APPLICANT	KIKKAWA		
	FILING DATE	June 11, 2001	GROUP	2661

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

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## FOREIGN PATENT DOCUMENTS

## TRANSLATION

	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
2H	JP-A-2000-138717	05/16/00	JAPAN				X (Abstract)	

\* Full English text of the JP Document will be available in machine-translated form from JP (Japanese Patent Office)  
English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	<i>Zewdu Habte</i>	DATE CONSIDERED <i>6/6/2005</i>

Rev. 10/94 (Form 3.05)

## PATENT APPLICATION

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FORM PTO-1449	ATTY. DKT NO. 01-156	SER. NO.
	APPLICANT KIKKAWA et al.	
	FILING DATE June 11, 2001	GROUP 2661

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## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
ZH	5,343,470 (discussed on p.3 of spec)	8/30/94	Hideshima et al.		
ZH	4,779,092	10/18/88	Takao		

## FOREIGN PATENT DOCUMENTS

## TRANSLATION

	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
ZH	JP-A-H4-63744	2/28/92	JAPAN				X	
ZH	JP-A-4-310444	11/2/92	JAPAN				X	
ZH	JP-A-7-327044	12/12/92	JAPAN				X	

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	Zewdu Habte	DATE CONSIDERED	6/6/2005
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